Acta Crystallographica Section E Structure Reports Online

ISSN 1600-5368

Asha Rani, Ajay Prakash Saha and Satya Murti Prasad*

Department of Physics, Ranchi University, Ranchi 834 008, India.

Correspondence e-mail: prasadsm50@hotmail.com

Key indicators

Single-crystal X-ray study T = 293 KMean $\sigma(C-C) = 0.003 \text{ Å}$ R factor = 0.058 wR factor = 0.183 Data-to-parameter ratio = 13.8

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

3-Oxo-2-(phenylhydrazono)butanoic acid

The non-hydrogen skeleton of the title molecule, $C_{10}H_{10}N_2O_3$, is planar and intramolecular $N-H\cdots O$ and $O-H\cdots O$ hydrogen bonds contribute to this planarity. The molecule exists in the space isomeric Z stereoisomer. Received 23 July 2002 Accepted 13 August 2002 Online 16 August 2002

Comment

As a part of our project to study the crystal structures of a series of phenylhydrazones and their stereochemistry, the crystal structure of the title compound, (I), has been determined. Earlier we reported the structure of 2-(2-methoxyphenylhydrazono)-3-oxobutanoic acid, (II) (Rani *et al.*, 2002). The bond lengths and angles in (I) show normal values and are comparable with those observed for (II). The molecule is planar, with atom O1 deviating by a maximum of 0.066 (2) Å. The planarity of the molecule is facilitated by intramolecular hydrogen bonds. The NH group forms an intramolecular



N−H···O hydrogen bond with the carbonyl O atom of the carboxyl group. The carbonyl O atom of the carbomethoxy group is also involved in an intramolecular O−H···O hydrogen bond with the carboxyl group (Fig. 1). In the crystal, the molecules exit as centrosymmetrically hydrogen-bonded dimers [N1−H1N···O2(1 − x, 1 − y, 2 − z)] (Table 2). Along the *a*-cell direction, the molecules related by inversion are stacked alternately 3.412 and 3.501 Å apart; these are optimum distances for π − π stacking interactions. The short contacts observed in the structure are listed in Table 3.



The structure of (I), showing 50% probability displacement ellipsoids and

Figure 1

© 2002 International Union of Crystallography Printed in Great Britain – all rights reserved

the atom-numbering scheme.

Experimental

The title compound was prepared by partial hydrolysis of ethyl 3-oxo-2-(2-phenylhydrazono)butyrate by the action of strong acids (Prasad *et al.*, 1994) and was recrystallized from methanol at room temperature.

 $Cu K\alpha$ radiation

reflections

 $\theta = 16.7 - 49.7^{\circ}$

 $\mu = 0.88 \text{ mm}^{-1}$ T = 293 (2) K

 $\begin{array}{c} \text{colourless} \\ 0.20 \times 0.15 \times 0.10 \text{ mm} \end{array}$

 $\theta_{\rm max} = 70.1^{\circ}$ $h = -8 \rightarrow 7$

 $k=0\to 25$

3 standard reflections

frequency: 60 min

intensity decay: none

 $l=0\to 8$

Cell parameters from 25

Needle (cut from a larger crystal),

Crystal data

 $\begin{array}{l} C_{10}H_{10}N_2O_3\\ M_r = 206.20\\ \text{Monoclinic, } P2_1/n\\ a = 6.9138 \ (10) \text{ Å}\\ b = 21.309 \ (2) \text{ Å}\\ c = 7.0783 \ (10) \text{ Å}\\ \beta = 108.917 \ (10)^\circ\\ V = 986.5 \ (2) \text{ Å}^3\\ Z = 4\\ D_x = 1.388 \ \text{Mg m}^{-3} \end{array}$

Data collection

Enraf–Nonius CAD-4 diffractometer ω –2 θ scans Absorption correction: none 2026 measured reflections 1878 independent reflections 1230 reflections with $I > 2\sigma(I)$ $R_{int} = 0.019$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.1093P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.058$	+ 0.0037P]
$wR(F^2) = 0.183$	where $P = (F_o^2 + 2F_c^2)/3$
S = 1.08	$(\Delta/\sigma)_{\rm max} < 0.001$
1878 reflections	$\Delta \rho_{\rm max} = 0.20 \text{ e} \text{ \AA}^{-3}$
136 parameters	$\Delta \rho_{\rm min} = -0.26 \text{ e } \text{\AA}^{-3}$
H-atom parameters constrained	

Table 1

Selected geometric parameters (Å, $^{\circ}$).

01-C8	1.309 (2)	N2-C7	1.311 (3)
O2-C8	1.227(2)	C7-C9	1.464 (3)
O3-C9	1.229 (3)	C7-C8	1.475 (3)
N1-N2	1.316 (2)	C9-C10	1.475 (3)
N1-C1	1.406 (2)		
N2-N1-C1	118.36 (16)	O2-C8-O1	120.6 (2)
C7-N2-N1	122.36 (17)	O2-C8-C7	122.23 (18)
C2-C1-N1	117.77 (18)	O1-C8-C7	117.16 (19)
C6-C1-N1	121.75 (19)	O3-C9-C7	120.1 (2)
N2-C7-C9	114.78 (19)	O3-C9-C10	120.5 (2)
N2-C7-C8	124.22 (18)	C7-C9-C10	119.38 (19)
C9-C7-C8	121.00 (19)		
C1-N1-N2-C7	178.89 (16)	C9-C7-C8-O2	-176.7(2)
N2-N1-C1-C2	177.63 (15)	N2-C7-C8-O1	-178.66 (19)
N2-N1-C1-C6	-3.9(3)	C9-C7-C8-O1	0.5 (3)
N1-C1-C2-C3	178.86 (16)	N2-C7-C9-O3	179.73 (18)
N1-C1-C6-C5	-179.66(19)	C8-C7-C9-O3	0.5 (3)
N1-N2-C7-C9	-177.78 (14)	N2-C7-C9-C10	-2.2(3)
N1-N2-C7-C8	1.5 (3)	C8-C7-C9-C10	178.5 (2)
N2-C7-C8-O2	4.1 (3)		

Table 2

Hydrogen-bonding geometry (Å, °).

$D - H \cdot \cdot \cdot A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - H \cdots A$
N1-H1N···O2	0.86	2.03	2.661 (2)	130
$N1 - H1N \cdots O2^i$	0.86	2.54	3.270 (2)	143
O1−H1O···O3	0.82	1.76	2.518 (2)	152

Symmetry code: (i) 1 - x, 1 - y, 2 - z.

Table 3	
Contact distances (Å).	

$O1 \cdot \cdot \cdot C2^i$	3.487 (3)	$C3 \cdot \cdot \cdot C9^{iv}$	3.423 (3)
O1···C10 ⁱⁱ	3.366 (3)	$C4 \cdot \cdot \cdot C7^{iv}$	3.587 (4)
$O2 \cdot \cdot \cdot O2^i$	2.907 (2)	$C5 \cdot \cdot \cdot C8^{iii}$	3.588 (4)
$O2 \cdot \cdot \cdot C2^i$	3.453 (3)	$C5 \cdot \cdot \cdot C8^{iv}$	3.390 (4)
C3···C9 ⁱⁱⁱ	3.507 (3)		. ,

Symmetry codes: (i) 1-x, 1-y, 2-z; (ii) x, y, 1+z; (iii) -x, 1-y, 1-z; (iv) 1-x, 1-y, 1-z.

After location in a difference Fourier map, all the H atoms were placed at calculated positions and were allowed to ride on their respective parent atoms using *SHELXL*97 (Sheldrick, 1997) defaults.

Data collection: *CAD-4 EXPRESS* (Enraf–Nonius, 1994); cell refinement: *CAD-4 EXPRESS*; data reduction: *MolEN* (Fair, 1990); program(s) used to solve structure: *SHELXS*97 (Sheldrick, 1997); program(s) used to refine structure: *SHELXL*97 (Sheldrick, 1997); molecular graphics: *ORTEP-3* (Farrugia, 1997); software used to prepare material for publication: *SHELXL*97.

The authors acknowledge, with thanks, Dr N. Prasad, Dr A. Sahay and their co-workers in the Department of Chemistry, BRA Bihar University, for the gift of crystals. The authors also thank the Regional Sophisticated Instrumentation Centre, Indian Institute of Technology, Chennai, India, for the collection of X-ray diffraction data.

References

Enraf-Nonius (1994). CAD-4 EXPRESS. Enraf-Nonius, Delft, The Netherlands.

Fair, C. K. (1990). MolEN. Enraf-Nonius, Delft, The Netherlands.

Farrugia, L. J. (1997). J. Appl. Cryst. 30, 565.

Prasad, N., Prasad, R. M., Sahay, A., Srivastava, A. K. & Prasad, J. (1994). *Asian J. Chem.* 6, 901–910.

Rani, A., Saha, A. P. & Prasad, S. M. (2002). Acta Cryst. E58, 0805-0806.

Sheldrick, G. M. (1997). SHELXS97 and SHELXL97. University of Göttingen, Germany.